

### This item is the archived peer-reviewed author-version of:

Strain, electric-field and functionalization induced widely tunable electronic properties in MoS2/BC3, /C3N and / C3N4 van der Waals heterostructures

#### **Reference:**

Bafekry Asadollah, Stampfl C., Ghergherehchi M..- Strain, electric-field and functionalization induced widely tunable electronic properties in MoS2/BC3, /C3N and / C3N4 van der Waals heterostructures Nanotechnology - ISSN 0957-4484 - 31:29(2020), 295202 Full text (Publisher's DOI): https://doi.org/10.1088/1361-6528/AB884E To cite this reference: https://hdl.handle.net/10067/1695230151162165141

uantwerpen.be

Institutional repository IRUA

#### ACCEPTED MANUSCRIPT

# Strain, electric-field and functionalization induced widely tunable electronic properties in MoS2/BC3 , /C3N and /C3N4 van der Waals heterostructures

To cite this article before publication: Asadollah Bafekry et al 2020 Nanotechnology in press https://doi.org/10.1088/1361-6528/ab884e

#### Manuscript version: Accepted Manuscript

Accepted Manuscript is "the version of the article accepted for publication including all changes made as a result of the peer review process, and which may also include the addition to the article by IOP Publishing of a header, an article ID, a cover sheet and/or an 'Accepted Manuscript' watermark, but excluding any other editing, typesetting or other changes made by IOP Publishing and/or its licensors"

This Accepted Manuscript is © 2020 IOP Publishing Ltd.

During the embargo period (the 12 month period from the publication of the Version of Record of this article), the Accepted Manuscript is fully protected by copyright and cannot be reused or reposted elsewhere.

As the Version of Record of this article is going to be / has been published on a subscription basis, this Accepted Manuscript is available for reuse under a CC BY-NC-ND 3.0 licence after the 12 month embargo period.

After the embargo period, everyone is permitted to use copy and redistribute this article for non-commercial purposes only, provided that they adhere to all the terms of the licence <u>https://creativecommons.org/licences/by-nc-nd/3.0</u>

Although reasonable endeavours have been taken to obtain all necessary permissions from third parties to include their copyrighted content within this article, their full citation and copyright line may not be present in this Accepted Manuscript version. Before using any content from this article, please refer to the Version of Record on IOPscience once published for full citation and copyright details, as permissions will likely be required. All third party content is fully copyright protected, unless specifically stated otherwise in the figure caption in the Version of Record.

View the article online for updates and enhancements.

3 4

5

6

7

8

9 10

11

12

13

14

15

16

17

18

19

20

21

22 23

24

25

26

27

28

29

30

31

32

33

34

35

36

37

38

39

40

41

42

43

44

45

46

47

48

49

50

51

52

53

54

55

56

## Strain, electric-field and functionalization induced widely tunable electronic properties in $MoS_2/BC_3$ , $/C_3N$ and $/C_3N_4$ van der Waals heterostructures

A. Bafekry,<sup>1,2,\*</sup> C. Stampfl,<sup>3</sup> and M. Ghergherehchi<sup>4,†</sup>

<sup>1</sup>Department of Physics, University of Guilan, 41335-1914 Rasht, Iran

<sup>2</sup>Department of Physics, University of Antwerp, Groenenborgerlaan 171, B-2020 Antwerp, Belgium

<sup>3</sup>School of Physics, The University of Sydney, New South Wales 2006, Australia

<sup>4</sup>College of Electronic and Electrical Engineering, Sungkyun kwan University, Suwon, Korea

In this paper, the effect of  $BC_3$ ,  $C_3N$  and  $C_3N_4$  substrates on the atomic and electronic properties of MoS<sub>2</sub> were systematically investigated using first-principles calculations. Our results show that the MoS<sub>2</sub>/ $BC_3$  and MoS<sub>2</sub>/ $C_3N4$  heterostructures are direct semiconductors with band gaps of 0.4 and 1.74 eV, respectively, while MoS<sub>2</sub>/ $C_3N$  is a metal. Furthermore, the influence of strain and electric field on the electronic structure of these van der Waals heterostructures is investigated. The MoS<sub>2</sub>/BC<sub>3</sub> heterostructure, for strains larger than -4%, transforms it into a metal where the metallic character is maintained for strains larger than -6%. The band gap decreases with increasing strain to 0.35 eV (at +2%), while for strain (> + 6%) a direct-indirect band gap transition is predicted to occur. For the MoS<sub>2</sub>/C<sub>3</sub>N heterostructure, the metallic character persists for all strains considered. On applying an electric field, the electronic properties of MoS<sub>2</sub>/C<sub>3</sub>N<sub>4</sub> are modified and its band gap decreases as the electric field increases. Interestingly, the band gap reaches 30 meV at +0.8 V/Å, and with increase above +0.8 V/Å, a semiconductor-to-metal transition occurs. Furthermore, we investigated effects of semi- and full-hydrogenation of MoS<sub>2</sub>/C<sub>3</sub>N and we found that it leads to a metallic and semiconducting character, respectively.

#### I. INTRODUCTION

The remarkable electronic, mechanical, and optical properties of two-dimensional materials (2D) and their ability to be tuned have opened the door to their potential applications in modern electronic, catalytic, energy conversion and storage devices.<sup>1–5</sup> This capability has been increased by stacking of different 2DM on top of each other to form artificial heterostructures that are bound by weak van der Waals (vdW) interaction.<sup>6–12</sup> These vdW heterojunctions are of potential interest for 2D electronic and optoelectronic technologies due to their atomically sharp interface, absence of dangling bonds and minimal trap states. Vertical 2D devices constructed with 2D semiconductor heterostructures have shown to exhibit interesting band gaps, higher power and higher speed than traditional bulk junctions.<sup>13,14</sup>

Recently, a particular class of 2DM, synthesized from boron, nitrogen and carbon atoms has attracted a lot of attention due to their outstanding chemical and physical properties. Layered nanomaterials composed soley of N, C and B atoms, which can take many different positions, enhance the possibilities to form strong covalent structures. A 2D honeycomb network with stoichiometry of  $BC_3$  has been synthesized experimentally.<sup>15–17</sup> By chemical synthesis, bulk  $BC_3$  was produced which forms stacked layers that are held together by the van der Waals (vdW) interaction.<sup>18</sup> Monolayer  $BC_3$  can be formed by exfoliation from the bulk counterpart, similar to the creation of graphene from graphite.<sup>19</sup> BC<sub>3</sub> shows excellent crystalline quality and has been shown to be a monolayer film.<sup>15</sup> Theoretical studies of BC<sub>3</sub> reported its electronic properties and showed that it is a semiconductor.<sup>20–23</sup>

2D polyaniline, with stoichiometry  $C_3N$  has a graphene-like structure.<sup>24</sup> Density-functional theory

(DFT) calculations demonstrated that the electronic properties of  $C_3N$  can be altered by different methods such as atom adsorption and functionalization,  $2^{5-29}$  as well as defects.<sup>30</sup> Like its  $C_2N$  counterparts,  $C_3N$  is also an intrinsic semiconductor as reported in recent theoretical studies. It has been reported that monolayer  $C_3N$  shows desirable properties for different applications, including nanoelectronics, hydrogen storage and catalysis.<sup>31–34</sup>  $C_3N_4$  exhibits semiconducting properties with the potential to be a photo-catalyst for water splitting.<sup>35,36</sup> This structure features intrinsic vacancies that may produce a spin polarized state. The electronic properties of  $C_3N_4$  are drastically modified when atoms are substituted.<sup>37–40</sup> Although two-dimensional materials (2DMs) hold significant potential for many applications, it will be necessary to tune their intrinsic properties. Several approaches have been considered to change the electronic structure of 2D BCN monolayers such as substitutional doping, defect engineering, application of an electric field or strain, surface functionalization by adatoms, or by altering the edge states.<sup>41–55,57–62,64</sup>

In this work, by *ab initio* calculations we investigate the electronic and atomic properties of heterostructures of  $MoS_2$  with  $BC_3$ ,  $C_3N$  and  $C_3N_4$ . We show that the band gap of these heterostructures can be modified by applying an electric field and by external strain. Finally, we study the electronic properties of  $MoS_2/C_3N$ and  $MoS_2/C_3N_4$  heterostructures under semi- and fullhydrogenation. We show that hydrogenation significantly modifies the electronic properties of these heterostructures and is able to induce metallic and semiconducting characteristics.



Figure 1. (a) Lattice structures and (b) calculated orbital resolved band structure of MoS<sub>2</sub>, BC<sub>3</sub>, C<sub>3</sub>N and C<sub>3</sub>N<sub>4</sub> monolayers. The primitive unit cell is indicated by a red parallelogram. The colors of band structures are weighted by the contributions from Mo-*d* orbitals: yellow lines for  $d_{xy}$  and  $d_{x^2-y^2}$ , red lines for  $d_{z^2}$ , and pink for  $d_{xz}$  and  $d_{yz}$ . Contributions from S-, B-, C- and N-*p* orbitals: blue lines for  $p_{x,y}$  and blue lines for  $p_z$ . Contributions from S-, B-, C- and N-*s* orbital: light red lines. The zero of energy is set to the Fermi level.

#### II. METHOD

scribed by Grimme (DFT-D2).<sup>71</sup>

In this work, we report results of our spin-polarized DFT calculations for the electronic structure as implemented in the OpenMX 3.8 package.<sup>65</sup> This code selfconsistently finds the eigenfunctions of the Kohn-Sham equations using norm-conserving pseudopotentials,<sup>66</sup> and pseudoatomic orbitals (PAOs).<sup>67,68</sup> The wave functions are expanded in a linear combination of multiple pseudoatomic orbitals (LCPAOs).<sup>67,68</sup> The PAO basis functions were specified by  $s^2p^2d^1$  for C, B, N and S atoms, while  $s^3p^2d^2$  for Mo atom within cutoff radii of basis functions set to the values of seven. We used the Perdew-Burke-Ernzerhof generalized gradient approximation (GGA) for the exchange-correlation functional.<sup>69</sup> The Monkhorst-Pack scheme<sup>70</sup> was used to generate the **k**-points for integration over the Brillouin zone (BZ) and the BZ is sampled by a mesh of  $15 \times 15 \times 1$ . After convergence tests, we chose different energy cutoffs (for instance 350 Ry, 400 Ry for pristine BCN monolayer and  $MoS_2/BCN$  heterostructure) so that the total-energy was converged to within 1.0 meV/atom. The atomic positions are optimized using a quasi-Newton algorithm for atomic force relaxation, where the structure was fully relaxed until the force acting on each atom was less than 1 meV/A. The heterostructures are modelled as a periodic slab with a large vacuum region (22 Å) in order to prevent interactions between adjacent layers. To describe the vdW interactions we use the empirical correction method de-

#### III. PRISTINE MONOLAYERS

We initially describe the atomic and electronic structure of the separate monolayers. The atomic structures of  $MoS_2$ ,  $BC_3$ ,  $C_3N$  and  $C_3N_4$  monolayers are shown in Fig. 1(a). The primitive unit cell is indicated by a red parallelogram. The MoS<sub>2</sub> monolayer consists of three layers with the Mo layer sandwiched between two S layers. We obtain for the lattice constant 3.21 Å, the vertical S-S distance 3.19 Å and the Mo-S bond length, 2.44 Å. These results are in agreement with previous reports.<sup>72</sup>  $BC_3$  has a planar structure with lattice constant 5.17 Å. The B-C and C-C bond lengths are, respectively, 1.56 and 1.42 Å, in agreement with earlier calculations.<sup>73,74</sup> We obtain a lattice constant of  $C_3N$  of 4.86Å, while the C-C and C-N bond lengths are 1.40 and 1.40 Å, respectively, as in agreement with previous reports.<sup>22,24,25</sup> After structural optimization, the lattice parameter of  $C_3N_4$  is determined to be 4.74 Å, and the two types of bond lengths of C-N are 1.32 and 1.44 Å, respectively, while the angle of N-C-N is  $117.4^{\circ}$ , which are in agreement with a previous calculation.<sup>75</sup>

The orbital-resolved band structure is shown in Fig. 1(b). Notice that BC<sub>3</sub> is a semiconductor with an indirect band gap of 0.7 eV, in which the valence band maximum (VBM) and conduction band minimum (CBM) are

1

13

14

15

22 23

24

25 26

27 28 29

30 31

32

33



Figure 2. Top and side views of the optimized atomic structures (right panel) and electronic band structure, DOS and PDOS (left panel) of (a)  $MoS_2/BC_3$ , (b)  $MoS_2/C_3N$  and (c)  $MoS_2/C_3N_4$  heterostructures. The zero of energy is set to the Fermi-level energy.

situated, respectively, at the  $\Gamma$  and M points, as found previously.<sup>73,74</sup> The VBM is composed of B/C- $p_{x,y}$  orbitals, and the CBM is composed of the  $p_z$  orbital between the B and C atoms. The effect of the *p*-orbitals can be clearly seen at the  $\Gamma$  point. This is very close to the *s* bonds at the VBM due to local distributions forming hexagonal rings. In deep energy levels, both types of *s*- and *p*-orbitals can be formed in C-C and B-C bonds. The C<sub>3</sub>N monolayer is an indirect semiconductor with a band gap of 0.4 eV, where the CBM and VBM are located at  $\Gamma$  and M, respectively. From the orbital-resolved band structure, it can be seen that the VBM (CBM) originates from N- $p_z$  (C- $p_z$ ) orbitals which is in agreement with previous studies.<sup>24,76,78</sup> Our results show that C<sub>3</sub>N<sub>4</sub> is a direct semiconductor with a band gap of 1.45 eV and the CBM and VBM are located at  $\Gamma$  point. N- $p_{x,y}$  orbitals are responsible for the VBM, while N/C- $p_z$  orbitals form the CBM, in agreement with previous reports.<sup>35,36</sup> We found that MoS<sub>2</sub> monolayer is a direct semiconductor with a band gap of 1.65 eV with both the CBM and the VBM located at the K-point.<sup>72</sup>

#### IV. PRISTINE HETEROSTRUCTURES

 $MoS_2$  is a transition metal dicalcogenide (TMD) monolayer that has been intensively investigated during the last decade. We use this material to form heterostructures with three different boron-carbon-nitride (BCN) monolayers. For the  $MoS_2/BCN$  heterostructures, we used a  $3 \times 3$  supercell of MoS<sub>2</sub> on top of a  $2 \times 2$  supercell of BCN, while the vacuum between is take to be 22 Å in these systems. The lattice mismatch ( $\delta$ ) is defined as  $\delta = \frac{|a_{up} - a_{dn}|}{a_{dn}} \times 100\%$ , where  $a_{up}$  and  $a_{dn}$  are the lattice constants of the unrelaxed top and bottom monolayers, respectively. The lattice mismatch between MoS<sub>2</sub> with BC<sub>3</sub>, C<sub>3</sub>N, C<sub>3</sub>N<sub>4</sub> monolayers are, respectively, 3.84%, 0.93% and 1.55%. Thus, relative to their freestanding structures, it is expected that there will be no major distortion in the geometric structures. We determine the lowest energy stacking configuration, including structural optimization. The different stacking patterns of  $MoS_2/BC_3$ ,  $MoS_2/C_3N$  and  $MoS_2/C_3N_4$  that we considered are shown in Fig. S1 of the supplementary information. The most stable stackings are found to be AA for MoS<sub>2</sub>/BC<sub>3</sub>, AB for MoS<sub>2</sub>/C<sub>3</sub>N and BB for  $MoS_2/C_3N_4$  as the relative total energies show in Fig. S2. The structural parameters including bond length, interlayer distance and buckling are shown in Fig. S3(a) and the values listed in Table I. The interlayer distance. between  $MoS_2$  and different monolayers are in the range of 3.13-3.33Å, which is typical of vdW equilibrium spacing. Here we investigate the electronic structure of different  $MoS_2/BCN$  systems. The band structure, density of states (DOS) and projected (PDOS) of  $MoS_2/BCN$ are shown in Figs. 2(a-c). We can see that  $MoS_2/BC_3$ is a semiconductor with a direct band gap of 0.4 eV, which compares with the band gaps of 0.7 eV and 1.26eV of  $MoS_2$  and  $BC_3$  monolayers, respectively. We can see from the PDOS that the VBM and CBM are mainly derived from Mo atom (see Fig. 3 (b)).  $MoS_2/C_3N$ , has no band gap due to the strong interaction between  $C_3N$ and  $MoS_2$ , and the heterostructure is a metal. This result agrees with a previous report.<sup>77</sup> From the PDOS,

Table I. The structural and electronic parameters of different  $MoS_2/BCN$  heterostructures shown in Fig. S3(a). The corresponding structural and electronic parameters including the lattice constants (a,b); the interlayer distance (D); the thickness (t) of  $MoS_2$  (distance between two S atoms). The bond length between C-C atoms  $(d_{C-C})$ , B(N)-C  $(d_{C-B(N)})$  atoms and Mo-S atoms; the buckling, defined by the difference between the largest and smallest z coordinates of atoms  $(\Delta z)$ . All distance are given in Å. Electronic states (ES) are specified as metal (M) and semiconductor (SC). The band gap is shown in parenthe- ses and is given in eV.

				<u> </u>							
Sys.	a	b	t	D	$\delta z$	$d_{C-B(N)}$	$\mathbf{d}_{C-C}$	$\mathbf{d}_{Mo-S}$	ES		
$BC_3$	10.08	10.08	3.10	3.21	0.39	1.52	1.40	2.48	SC(0.4)		
$C_3N$	9.72	9.72	3.16	3.33	0.0	1.40	1.40	2.44	М		
$C_3N_4$	9.50	9.47	3.21	3.13	1.33	1.34 - 1.47	-	2.43	SC(1.74)		

we found that the metallic character near the Fermi level originates from Mo (see Fig. 3(b)). The  $MoS_2/C_3N_4$  is a direct semiconductor with a band gap of 1.74 eV and the PDOS shows that both  $MoS_2$  and  $C_3N_4$  affect the electronic states near the Fermi level and there is a strong interaction between the two layers (see Fig. 3(c)).

#### V. EFFECT OF ELECTRIC FIELD ON THE HETEROSTRUCTURES

Electrostatic gating is an effective way to tune the injection of carriers, the band structures and the electron redistribution in the heterostructure. The electronic band structure of the  $MoS_2/BCN$  heterostructures in the presence of a perpendicular electric field are shown in Figs. 5(a-c). The strength of electric field >0 (<0) denotes parallel (antiparallel) to the z-axis. It can be seen that the electric field can change the electronic structure of  $MoS_2/BC_3$  significantly with a decrease in the band gap up (see Fig. 3(c)), and thus a semiconductor-tometal transition occurs. The electric field dependence of  $MoS_2/C_3N$  is very different from the other two heterostructures and in this case, a negative electric field is able to open a band gap. When the applied negative electric field reaches -0.6 V/Å, and -0.8 V/Å, the band gap is 0.25 eV and 0.42 eV, respectively. We investigated that for the electric field varying from -0.8 to -1.2 V/Å, the band gap stays constant at  $\sim 0.42$  eV. In contrast, for  $MoS_2/C_3N_4$ , on applying an electric field, its band gap decreases for both for positive and negative electric field values. The band gaps are calculated 1.3 eV (at +0.2 V/Å), 0.8 eV (at +0.4 V/Å), 0.4 eV (at +0.6 V/Å). Interestingly, the band gap reaches 30 meV at +0.8 V/Å and for further increase of the electric field, a semiconductor-to-metal transition occurs. Notice that different heterostructures response differently to the applied external E-field. For example, the VBM of  $MoS_2/C_3N$  is dominated by  $MoS_2$  layer, while the CBM originates from  $C_3N$  monolayer. In addition, given by Fig. 1, the VBM of  $MoS_2$  is dominated by in-plane dorbitals of the Mo atom while the CBM of  $C_3N$  is dominated by the  $p_z$ -orbitals of C atoms. Apparently, an applied out-of-plane electric field significantly affects C $p_z$  orbitals, while in-plane *d*-orbitals of Mo are slightly affected. In contrast, in the case of  $MoS_2/C_3N_4$ , both the VBM and CBM are affected by the applied field due to out-of-plane orbitals contributing to both band edges. Overall, depending on the atomic orbital characters of the band edges, the material response differently to the external effects. This electric field tuning of the band gaps, over a wide range for the  $MoS_2/BCN$  heterostructures are expected to lead to important applications in nanoscale electronic and optoelectronic devices.



Figure 3. (a) Schematic view, (b) electronic band structure and (c) band gaps of  $MoS_2/BC_3$ ,  $MoS_2/C_3N$  and  $MoS_2/C_3N_4$  heterostructures with applied electric field. Electric field >0 and <0, denotes parallel and antiparallel to the z-axis, respectively. The zero of energy is set to the Fermi level energy.

#### VI. EFFECT OF STRAIN ON THE HETEROSTRUCTURES

Strain engineering is a robust method to tune the electronic properties and the topological nature.<sup>79,80</sup>

In the following, we explore the effect of strain on the electronic structure of  $MoS_2/BCN$ . The strain is defined as  $\varepsilon = (a \pm a_0)/a_0 \times 100$ , where a and  $a_0$  are the strained and non-strained lattice constants, respectively, and the positive (negative) sign denotes tensile (compressive) strain. The electronic band structure under uniaxial strain are shown in Figs. 4(a-c). The schematic views of the heterostructures with applied strain are shown in Fig. S4. Our results show that  $MoS_2/BC_3$ , under -2% strain, is a semiconductor with a direct band gap of 0.3 eV, while the CBM and VBM are located at the  $\Gamma$  point. When compressive strain increases beyond -4%, the heterostructure transforms into a metal. Notice that the band gap disappears during the compression, the in-plane strain distorts the *p*-orbitals of C atoms which have contribution to the VBM of the heterostructure. We found that the direct band gap decreases with increasing tensile strain to 0.35 eV (at +2%) and 0.3 eV (at +4%). While for large strain (> + 6%) a direct-indirect band gap transition is predicted to occur. The values of band gaps are determined to be 0.25 eV (at +6%) and 0.15 eV (at +8%). We see that  $MoS_2/C_3N$ , under large uniaxial strain, remains metallic.

Our result show that  $MoS_2/C_3N_4$  heterostructure under uniaxial strain for larger magnitudes of +2% (tensile) the energy band gap be decreases from 1.4 eV, (at +4%) to 1.1 eV (at +8%). Interestingly, we found that when the tensile uniaxial strain surpasses the critical value of +6%, the direct band gap of the heterostructure changed to indirect. Similar to the tensile strain case, for compression strain the band gap decreases from 1.25 eV (at -4%)



Figure 4. Electronic band structure of (a)  $MoS_2/BC_3$ , (b)  $MoS_2/C_3N$  and (c)  $MoS_2/C_3N_4$  heterostructures under uniaxial strain. The zero of energy is set to the Fermi level energy. Band gap variation with (d) uniaxial strain and (e) biaxial strain.



Figure 5. Optimized atomic structures of (a,b) semi- and (c) fully-hydrogenated  $MoS_2/BC_3$ . Optimized atomic structures of (d,e) semi- and (f) fully- hydrogenated of  $MoS_2/C_3N$ . Electronic band structure of both structures are shown in the bottom panels. The zero of energy is set to the Fermi level energy.

to 0.8 eV (at -8%) and we can see a direct-to-indirect band gap transition occurs and the VBM and CBM are located at  $\Gamma$  and M points, respectively. The variations of band gap with respect to both strains are shown in Figs. 4(d,e), while the electronic band structure of MoS<sub>2</sub>/BCN

under a biaxial strain are shown in Fig. S4.

It is found that  $MoS_2/BC_3$  is initially a semiconductor with a 0.4 eV direct band gap. We see that with increasing biaxial strain from +2% to +8% the direct band gap decreases to 0.37 eV (at +2%), 0.32 eV (at

3

> 59 60

+4%), 0.26 eV (at +6%) and 0.2 eV (at +8%) and its semiconducting character is preserved. This situation is different for compression strain, so upon a biaxial strain -2% MoS<sub>2</sub>/BC<sub>3</sub> is a semiconductor with a direct band gap of 0.2 eV. Interestingly, when the compressive strain reaches -4%, the heterostructure transforms into a metal and the metallic character is preserved for magnitude of strains larger than -4%. MoS<sub>2</sub>/C<sub>3</sub>N<sub>4</sub> is a semiconductor in the non-strained state and has a direct band gap of 1.7 eV. Our results show that with increase of magnitude biaxial strain from -2% to -4%, the band gap decreases from 1.75 to 1.6 eV and a direct-to-indirect band gap transition occurs. While for strain from -6% to -8%, an indirect-to-direct band gap transition with values of 1.42 eV and 1.2 eV, respectively, occurs. We can see that with increase of strain from +2% to +8%, the direct band gap changes to indirect and decreases with values of 1.6 (+2)%) to 1.1 eV (+8%). These results reveal strain engineering dependent band gaps and electronic state transitions in the  $MoS_2/BCN$  heterostructures, as well as the band gap changes between direct and indirect which could be of use in high-performance electronic and optoelectronic devices.

#### VII. HYDROGENATION OF ON THE HETEROSTRUCTURES

Adsorption of atoms on the surface of a structure can be an effective way to tune the properties of twodimensional materials. We discuss here the modifications that occurs in the electronic properties by hydrogenation. We explore the structural and electronic properties of semi and full coverages of hydrogen atoms on  $MoS_2/BC_3$ and  $MoS_2/C_3N$  heterostructures. After full optimization we found that hydrogen atoms adsorb on carbon atoms with bonds oriented normal to the  $BC_3$  and  $C_3N$  planes. The optimized atomic structures of semi hydrogenated and fully hydrogenated  $MoS_2/BC_3$  and  $MoS_2/C_3N$  are shown in top panel of Fig. 5. We consider two types of semi hydrogenated and are labeled theme as SH1(when H atoms functionalize between two layers) and SH2 (when H atoms functionalize on top of BC<sub>3</sub> and  $C_3N$  layers), while fully hydrogenated labeled as FH. The structural parameters including bond length, interlayer distance and buckling are shown in Fig. S3(b) and the values are listed in Table II.

For semi and fully hydrogenated  $MoS_2/C_3N$ , there is a small increase of the lattice constant from 9.72 Å in  $MoS_2/BC_3$ , to 9.74 Å (semi) and 9.76 Å (fully). The increase in lattice parameter is due to the increase in bond lengths, which changes from 1.40 to 1.47 Å (*SH*1, *SH*2) and 1.52 Å (*FH*). The buckling for semi and fully hydrogenated are calculated in the range of 0.47-0.62 Å, while, the C-H bond lengths are 1.14 Å (*SH*1) and 1.15 Å (*SH*2) and 1.11 Å (*FH*). In general, the C-C and C-N bond lengths without hydrogenation are smaller compared to those between the N and C atoms

Table II. The structural and electronic parameters of different semi- and fully-hydrogenated MoS<sub>2</sub>/BCN heterostructures shown in Fig. S3(b). Semi hydrogenated is labeled as SH1 (when H atoms functionalize between two layers) and SH2 (when H atoms functionalize on top of BC<sub>3</sub> and C<sub>3</sub>N layers), while fully hydrogenated is labeled as FH. The corresponding structural and electronic parameters including the lattice constant (a); bond length between C-C atoms  $(d_{C-C})$ ; the bond length between C-N atoms  $(d_{C-N})$ ; the bond length between H atom and the nearest-neighbor C atom  $(d_{H-C})$ ; the interlayer distance of between the H and S atom (D); the buckling, defined by the difference between the largest and smallest z coordinates of atoms ( $\Delta z$ ). All distance are given in Å. Electronic states (ES) are specified as semi-metal (SM)and semiconductor (SC). The band gap is shown in parentheses and is given in eV.

0							
Sys.	a	$d_{C-C}$	$d_{C-B,N}$	$d_{H-C}$	D	$\Delta z$	ES
$MoS_2/BC_3$ (SH1)	10.26	1.45	1.50	1.15	2.79	0.62	М
$MoS_2/BC_3$ (SH2)	10.15	1.55	1.61	1.12	2.04	1.66	М
$MoS_2/BC_3$ (FH)	10.26	1.45	1.50	1.15	2.26	0.22	M
$MoS_2/C_3N$ (SH1)	9.74	1.48	1.47	1.14	2.71	0.59	М
$MoS_2/C_3N$ (SH2)	9.72	1.47	1.38	1.15	3.40	0.62	М
$MoS_2/C_3N$ (FH)	9.76	1.52	1.46	1.11	2.99	0.47	SC(0.9)

with one or both N and C atoms bonded to H atoms. The electronic band structure of semi and fully hydrogenated  $MoS_2/BC_3$  and  $MoS_2/C_3N$  are shown in Figs. 5(a-f). In comparison to pristing  $MoS_2/BC_3$ , we can see that the electronic structure is modified due to the functionalization. We fund that a semiconducting behavior with band gap of 0.9 eV, where the VBM and CBM are located at K and  $\Gamma$  points. Our results show that impurity states appear around the Fermi-energy, and induce a metallic character. Interestingly, for the case of hydrogen atoms between two layers, the structure is strongly distorted and  $MoS_2$  and  $BC_3$  bond together and we can see a metallic characteristic as for the pristine  $MoS_2/BC_3$ heterostructure. Notice,  $MoS_2/C_3N$  is a metal and the metallic character remains with semi hydrogenation. For fully hydrogenated  $MoS_2/C_3N$ , the system changes from a metal to semiconductor.

#### VIII. CONCLUSION

In summary, we performed an extensive study of the structural and electronic properties of a  $MoS_2$  monolayer on  $BC_3$ ,  $C_3N$  and  $C_3N_4$  monolayers using first-principles calculations. The results show a wide variety of electronic properties which differ from the monolayers. Our results showed that  $MoS_2/BC_3$  is a semiconductor with a direct band gap of 0.4 eV, while  $MoS_2/C_3N$  is a metal. In addition,  $MoS_2/C_3N_4$  is a direct semiconductor with a band gap of 1.74 eV. The band structure of these heterostructures can be adjusted by application of an electric field and strain.  $MoS_2/BC_3$ , under -2% strain, is a semiconductor with a direct band gap of 0.3 eV and when uniaxial strain increases to larger than -4%, it transforms into a metal, and the metallic character is preserved for

strains larger than -6%. For large strain (> + 6%), a direct-indirect band gap transition occurs.  $MoS_2/C_3N$ remains metallic for all strain values considered. On application of an electric field the band gap of  $MoS_2/C_3N_4$ decreases with increasing electric field. Interestingly, the band gap reaches 30 meV at +0.8 V/Å and with increasing electric field larger than +0.8 V/Å, a semiconductorto-metal transition is occurs. We also investigate effects of semi and fully functionalization by H atom adsorption and found that the electronic properties are modified. The  $MoS_2/C_3N$  heterostructdure with fully hydrogenation transform from a metal to semiconductor. Tuning of the electronic structure in these ways leads to the potential exotic properties that could make such heterostructures of interest for future investigations and for appli-

- \* Bafekry.asad@gmail.com
- <sup>†</sup> mitragh@skku.edu
- <sup>1</sup> F. Bonaccorso, L. Colombo, G. Yu, M. Stoller, V. Tozzini, A. C. Ferrari, R. S. Ruoff, V. Pellegrini, *Sci.* 2015, **347**, 1246501.
- <sup>2</sup> C. Tan, H. Zhang, *Nat. Commun.* 2015, **6**, 7873.
- <sup>3</sup> B. Luo, G. Liu, L. Wang, *Nanoscale* 2016, **8**, 6904.
- <sup>4</sup> C. Tan, X. Cao, X.-J. Wu, Q. He, J. Yang, X. Zhang, J. Chen, W. Zhao, S. Han, G.-H. Nam, M. Sindoro, H. Zhang, *Chem. Rev.* 2017, **117**, 6225.
- <sup>5</sup> J. Di, J. Xiong, H. Li, Z. Liu, Adv. Mater. 2018, **30**, 1704548.
- <sup>6</sup> H. Li , J. Wu , Z. Yin H. Zhang Acc. Chem. Res. 2014, 47, 1067.
- <sup>7</sup> W. Su , H. Dou , J. Li , D. Huo , N. Dai, L. Yang , *RSC Adv.* 2015, 5, 82924.
- <sup>8</sup> M. Buscema , G. A. Steele , H. S. J. van der Zant, A. Castellanos-Gomez, *Nano Res.* 2014, 7, 561.
- <sup>9</sup> W. Su, H. Dou, D. Huo, N. Dai, L. Yang, *Chem. Phys. Lett.* 2015, **635**, 40.
- <sup>10</sup> S. Mouri , Y. Miyauchi K. Matsuda, *Nano Lett.* 2013, **13**, 5944.
- <sup>11</sup> X. Zhou , W. Feng , S. Guan , B. Fu , W. Su, Y. Yao, J. Mater. Res. 2017, **32**, 2993.
- <sup>12</sup> Y. Deng , Z. Luo , N. J. Conrad , H. Liu , Y. Gong , S. Najmaei , P. M. Ajayan , J. Lou , X. Xu, P. D. Ye, ACS Nano 2014, 8, 8292.
- <sup>13</sup> J. Yan, Y. Hao, Y. Cui, J. Zhang, Y. Zou, W. Zhang, G. Yu, J. Zheng, W. Xu, D. Zhu, *J. Mater. Chem. C* 2018, **6**, 12976.
- <sup>14</sup> K. H. Chan , S. M. Ng , H. F. Wong , C. W. Leung, C. L. Mak, *Phys. Status Solidi A* 2019, **216**, 1800829.
- <sup>15</sup> H. Yanagisawa, T. Tanaka, Y. Ishida, M. Matsue, E. Rokuta, S. Otani, C. Oshima, *Phys. Rev. Lett.* 2004, **93**, 177003.
- <sup>16</sup> H. Tanaka, Y. Kawamata, H. Simizu, T. Fujita, H. Yanagisawa, S. Otani, C. Oshima *Solid State Commun.* 2005, **136**, 22.
- <sup>17</sup> H. Yanagisawa, T. Tanaka, Y. Ishida, M. Matsue, E. Rokuta, S. Otani, C. Oshima, *Phys. Rev. B* 2006, **73**, 045412.
- <sup>18</sup> J. Kouvetakis, R. B. Kaner, M. L. Sattler, N. Bartlett, J. Chem. Soc. Chem. Commun. 1968, **24**, 1758.

cations in emerging technological devices with precisely controlled properties.

#### IX. CONFLICTS OF INTEREST

The authors declare that there are no conflicts of interest regarding the publication of this paper.

#### X. ACKNOWLEDGMENTS

This work has supported by the National Research Foundation of Korea(NRF) grant funded by the Korea government(MSIT)(NRF-2017R1A2B2011989).

- <sup>19</sup> K. S. Novoselov, D. Jiang, F. Schedin, T. J. Booth, V. V. Khotkevich, S. V. Morozov, A. K. Geim, *PNAS* 2005, **102**, 10451.
- <sup>20</sup> D. Tomanek, R. M. Wentzcovitch, S. G. Louie, M. L. Cohen, *Phys. Rev. B* 1988, **37**, 3134.
- <sup>21</sup> T. Sasaki, M. Akaishi, S. Yamaoka, Y. Fujiki, T. Oikawa, *Chem. Mater.* 1993, **5**, 695.
- <sup>22</sup> A. Bafekry, S. Farjami Shayesteh, M. Ghergherehchi, F. M. Peeters, J. Appl. Phys. 2019, **126**, 144304.
- <sup>23</sup> Y. Ding, Y. Wang, J. Ni, Appl. Phys. Lett. 2009, 94, 073111.
- <sup>24</sup> J. Mahmood, E. K. Lee, M. Jung, D. Shin, H. J. Choi, J. M. Seo, S. M. Jung, D. Kim, F. Li , M. S. Lah, N. Park , H. J. Shin, J.H. Oh, J. B. Baek, *PNAS* 2016, **113**, 7414.
- <sup>25</sup> A. Bafekry, S. F. Shayesteh, F. M. Peeters, J. Phys. Chem. C. 2019, **123**, 12485.
- <sup>26</sup> M.B. Tagani, Comput. Mater. Sci. 2018, **153**, 126.
- <sup>27</sup> A. Bafekry, M. Ghergherehchi, S. Farjami Shayesteh, F.M. Peeters, *Chem. Phys.* 2019, **526**, 110442.
- <sup>28</sup> A. Bafekry, C. Stampfl, S. Farjami Shayesteh, F. M. Peeters, Adv. Elec. Mater. 2019, doi:10.1002/aelm.201900459.
- <sup>29</sup> M.B. Tagani, S.I. Vishkayi, J. Appl. Phys. 2018, **124**, 084304.
- <sup>30</sup> A. Bafekry, S. Farjami Shayesteh, F.M. Peeters, *Phys. Chem. Chem. Phys.* 2019, **21**, 21070.
- <sup>31</sup> A. Bafekry, C. Stampfl, S. Farjami Shayesteh, *ChemPhysChem* **21**, 164.
- <sup>32</sup> M.D. Esrafili, S. Heydari, *Theor. Chem. Acc.* 2019, **138**, 57.
- <sup>33</sup> O. Faye, T. Hussain, A. Karton, J. Szpunar, Nanotech. 2018, **30**, 75404.
- <sup>34</sup> A. Bafekry, C. Stampfl, M. Ghergherehchi, S. Farjami Shayesteh, *Carbon* 2020, **157**, 371.
- <sup>35</sup> Zh. Guizhi, L. Kun, S. Qiang, K. Yoshiyuki, J. Puru, *Comput. Mater. Sci.* 2014, **81**, 275.
- <sup>36</sup> X. Li, S. Zhang and Q. Wang, *Phys. Chem. Chem. Phys.* 2013, **15**, 7142.
- <sup>37</sup> S.I. Vishkayi, M.B. Tagani, Nano-micro letters 2018, 10, 14.
- <sup>38</sup> A. Bafekry, C. Stampfl, B. Akgenc, M. Ghergherehchi, *Phys. Chem. Chem. Phys.* 2020, **22**, 2249.

2

3

4

5

6

7

8

9

10

11

12

13

14

15

20

21

22

23

24

25

26

27

28

29

30

31

32

33

34

35

36

37

38

39

40

41

42

43

44

45

46

47

48

49

2

3

4

5

6

7

8

9

10

11

12

13

14

15

16

17

18

19

20

21

22

23

24

25

26

27

28

29

30

31

32

33

34

35

36

37

38

39	S.	I.	Vish	kayi,	M.B.	Tagani,	J.	Phys.	D:	Appl
	$Ph_{2}$	ys.	2020.	doi=	http://	iopscience	e.iop.	org/10.	1088	/1361-
	646	53/a	ab7bb3	3.						

- <sup>40</sup> A. Bafekry, S. Farjami Shavesteh, F. M. Peeters, J. Appl. Phys. 2019, 126, 215104.
- 41 F. Ersan, O. Arslanalp, G. Gokoglu, E. Akturk, Appl. Surf. Sci 2014, 311, 9.
- 42M. M. Oeid, Appl. Surf. Sci 2020, 508, 144824.
- 43A. Bafekry, Physica E: Low-dimensional Systems and Nanostructures 2020, 118, 113850.
- <sup>44</sup> M. Yagmurcukardes, C. Sevik, F. M. Peeters, *Phys. Rev.* B 2019, 100, 045415.
  - <sup>45</sup> F. Ersan, S. Cahangirov, G. Gokoglu, A. Rubio, E. Akturk, Phys. Rev. B 2016, 94(15), 155415
  - <sup>46</sup> A. Bafekry, C. Stampfl, B. Akgenc, B. Mortazavi, M. Ghergherehchi, Ch. V. Nguyen, Phys. Chem. Chem. Phys., 2020. doi: https://doi.org/10.1039/D0CP00093K
  - <sup>47</sup> D. Kiymaz, M. Yagmurcukardes, A. Tomak, H. Sahin, R. T. Senger, F. M. Peeters, H. M. Zareie and C. Zafer, Nanotechnology 2016 27, 455604.
  - <sup>48</sup> C. Nguyen, H. Nguyen, *Chem. Phys.* 2016, **468**, 9.
  - 49A. Bafekry, B. Akgenc, S. Farjami Shayesteh, B. Mortazavi, Appl. Surf. Sci. 2020, 505, 144450.
  - <sup>50</sup> F. Ersan, S. Sarikurt, Phys. Chem. Chem. Phys 2019, **21(36)**, 19904-19914
  - <sup>51</sup> F. Iyikanat, M. Yagmurcukardes, R. T. Senger, H. Sahin, J. Mater. Chem. C, 2018, 6, 2019.
  - 52A. Bafekry, M. Neek-Amal, Phys. Rev. B 2020, 101, 085417.
  - <sup>53</sup> Huynh V. Phuc, Tuan V. Vu, Nguyen N. Hieu, Victor .V. Ilvasov, Igor A. Fedorov, Bui D. Hoi, Le T. T. Phuong, Nguyen V. Hieu, E. Feddi, Chuong V. Nguyen, J. Electronic Mater. 2018, 47, 4594.
  - 54Z. Kahraman, A. Kandemir, M. Yagmurcukardes, H. Sahin, J. Phys. Chem. C 2019, 123, 4549.
  - 55A. Bafekry, C. Stampfl, F. M. Peeters, Sci. Rep. 2020, 10, 213.
  - 56M. M. Oeid, Appl. Surf. Sci 2020, 508, 144824.
  - Khang D. Pham, Nguyen N. Hieu, Le M. Bui, Huynh V. Phuc, Le T. N. Tu, Long G. Bach, Victor V. Ilyasov, Bin Amin, M. Idrees, Chuong V. Nguyen, Chem. Phys. Lett. 2019, 716 155.

- B. Mortazavi, A. Bafekry, M. Shahrokhi, T. Rabczuk, X. Zhuang, Materials Today Energy 2020, 16, 100392.
- <sup>59</sup> M. Yagmurcukardes, S. Ozen, F. Iyikanat, F. M. Peeters, H. Sahin, Phys. Rev. B 2019, 99, 205405.
- <sup>60</sup> M. M. Obeid, H. R. Jappor, K. Al-Marzoki, D. M. Hoatc, T. V. Vu, S. J. Edrees, Z. M. Yaseen, M. M. Shukur, Comput. Mater. Sci. 2019, 170, 109201.
- A. Bafekry, M. Ghergherehchi, S. Farjami Shayesteh, Phys. Chem. Chem. Phys. 2019, 21, 10552.
- <sup>62</sup> Tuan V. Vu, Nguyen V. Hieu, Le T. P. Thao, Nguyen N. Hieu, Huynh V. Phuc, H. D. Bui, M. Idrees, B. Amin, Le M. Duc, Chuong V. Nguyen, Phys. Chem. Chem. Phys. 2019, 21, 22140.
- <sup>63</sup> Superlattice. Microst. 2019, **130**, 545.
- <sup>64</sup> A. Bafekry, B. Mortazavi, S. Farjami Shayesteh, J. Magnetism and Magnetic Mater. 2019, 491, 165565.
- <sup>65</sup> T. Ozaki, K. Nishio, H. Kino, Phys. Rev. B 2010, 81, 035116.
- <sup>66</sup> N. Troullier, J. Martins, *Phys. Rev. B* 1991, **43**, 1993.
  <sup>67</sup> T. Ozaki, *Phys. Rev. B* 2003, **67**, 155108.
- <sup>68</sup> T. Ozaki, H. Kino, *Phys. Rev. B* 2004, **69**, 195113.
- 69 J. P. Perdew, K. Burke, M. Ernzerhof, Phys. Rev. Lett. 1996, 77, 3865.
- <sup>70</sup> Monkhorst, H. J. Pack, J. D. Phys. Rev. B 1976, **13**, 5188.
- <sup>71</sup> T. Buko, J. Hafner, S. Lebgue and J. G. ngyn, *Phys. Chem.* A 2010, **114**, 118145.
- <sup>72</sup> K. M. Mak, Ch. Lee, J. Hone, J. Shan, T. F. Heinz, Phys. *Rev. Lett.* 2010, **105**, 136805.
- Y. Ding, Y. Wang, J. Ni, J. Phys. Chem. C 2010, 114, 12416.
- <sup>74</sup> S. Behzad, Surf. Sci. 2017, 665, 37.
- <sup>75</sup> E. Kroke, M. Schwarz, E. Horath-Bordon, P. Kroll, Br. Noll and A. D. Norman, New J. Chem. 2002, 26, 508.
- O. Hu, O. Wu, H. Wang, J. He and G. Zhang, Physica Status Solidi (b) 2011. 249, 784-788.
- 77 Y. Yang, Zh. Wang, RSC Adv., 2019, 9, 19837.
- 78 H. J. Xiang, B. Huang, Z. Y. Li, S.-H. Wei, J. L. Yang and X. G. Gong, Phys. Rev. X 2, 2012, 011003.
- K. P. Katin, K. S. Krylov, M. M. Maslov, V. D. Mur, Diamond and Related Materials, 2019, 100, 107566
- I. Y. Sahalianov, T. M. Radchenko, V. A. Tatarenko, G. Cuniberti, Y. I. Prylutskyy, J. Appl. Phys. 2019, 126, 054302.